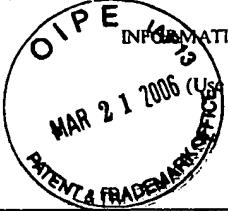
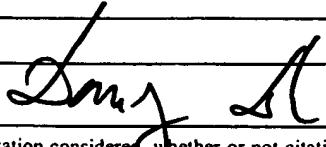


| Form PTO-1449 (REV. 1/06)  US Dept. of Commerce PATENT & TRADEMARK OFFICE INFORMATION DISCLOSURE STATEMENT (Use several sheets if necessary) | | | ATTY DOCKET NO. 118118 | APPLICATION NO. 10/736,644 | | |
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| | | | APPLICANT(S) Hiroyuki OGI | | | |
| | | | FILING DATE December 17, 2003 | GROUP 2834 | | |
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| FEB 10 2006 U.S. PATENT & TRADEMARK OFFICE | | | FILING DATE December 17, 2003 | GROUP 2834 | |
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| EXAMINER <i>Samy Sh</i> | | | | | DATE CONSIDERED <i>3/23/06</i> |
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